

<b>Notice of References Cited</b>	Application/Control No. 10/764,444	Applicant(s)/Patent Under Reexamination DAIROKU ET AL.	
	Examiner Keith J. Godfrey	Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,365,644 B1	04-2002	Yamamura et al.	522/168
*	B	US-2004/0092688 A1	05-2004	Dairoku et al.	526/317.1
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	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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